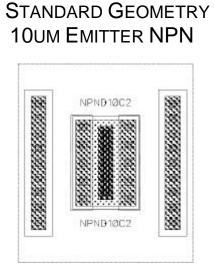
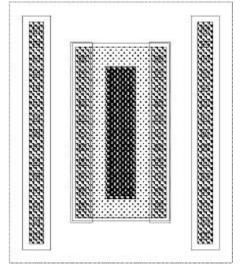


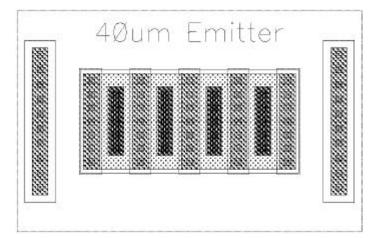
TRT Test Structures Fabricated by Temic January 99



INPUT PROTECTION SHIELDED (COLLECTOR) BASE EMITTER DIODE 20UM EMITTER NPN



IMPROVED ROBUSTNESS, BETTER R_B EXPANDED GEOMETRY MULTI-STRIPE 4 X 10UM EMITTER NPN



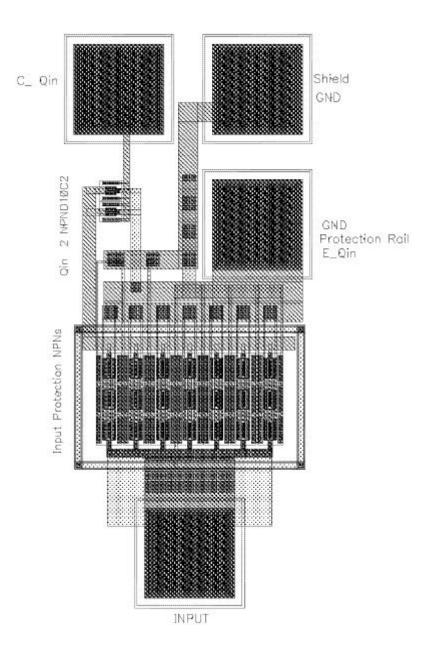
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DMILL TEST STRUCTURES

Shielded Input Protection With Standard NPN Amplifier primitive

Fails above 1.2 Mj Impulse Discharge No Leakage observed up to 10¹⁴ P/cm²



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